

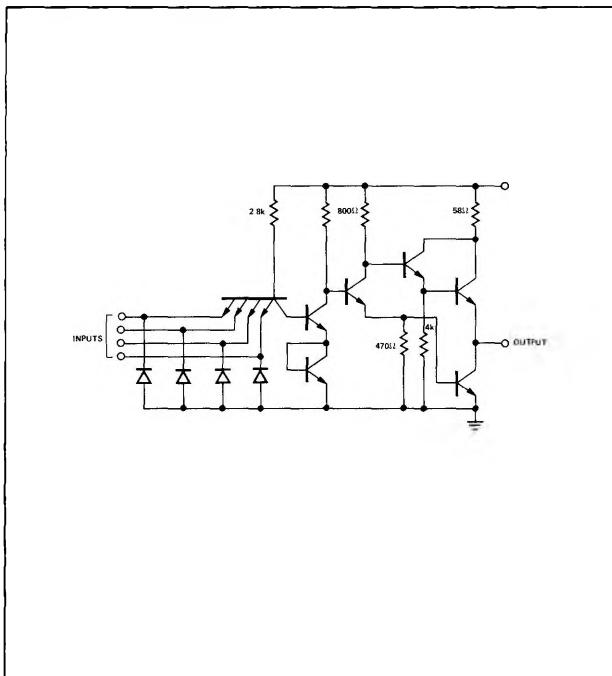
DUAL 4-INPUT POSITIVE AND GATE

**S54H21
N74H21**

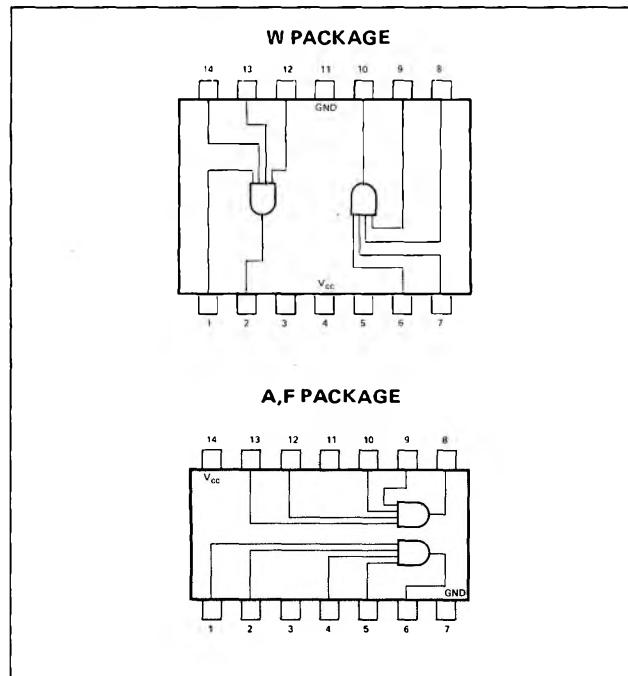
S54H21-A,F,W • N74H21-A,F

DIGITAL 54/74 TTL SERIES

SCHEMATIC (each gate)



PIN CONFIGURATIONS



RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
Supply Voltage V_{CC} :	S54H21 Circuits	4.5	5	5.5	V
	N74H21 Circuits	4.75	5	5.25	V
Normalized Fan-Out from each Output, N				10	
Operating Free-Air Temperature Range, T_A :	S54H21 Circuits	-55	25	125	°C
	N74H21 Circuits	0	25	70	°C

ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*	TEST CONDITIONS*			UNIT
		MIN	TYP**	MAX	
$V_{in(1)}$	$V_{CC} = \text{MIN}$,		2		V
$V_{in(0)}$	$V_{CC} = \text{MIN}$,			0.8	V
$V_{out(1)}$	$V_{CC} = \text{MIN}$, $I_{load} = -500\mu\text{A}$	$V_{in(1)} = 2\text{V}$,	2.4		V
$V_{out(0)}$	$V_{CC} = \text{MIN}$, $I_{sink} = 20\text{mA}$	$V_{in(0)} = 0.8\text{V}$,		0.4	V
$I_{in(0)}$	$V_{CC} = \text{MAX}$,	$V_{in} = 0.4\text{V}$		-2	mA
$I_{in(1)}$	$V_{CC} = \text{MAX}$, $V_{CC} = \text{MAX}$,	$V_{in} = 2.4\text{V}$ $V_{in} = 5.5\text{V}$		50 1	μA mA
I_{OS}	$V_{CC} = \text{MAX}$,	$V_{in} = 4.5\text{V}$	-40	-100	mA
$I_{CC(0)}$	$V_{CC} = \text{MAX}$,	$V_{in} = 0$	20	32	mA
$I_{CC(1)}$	$V_{CC} = \text{MAX}$,	$V_{in} = 4.5\text{V}$	12	20	mA

SIGNETICS DIGITAL 54/74 TTL SERIES — S54H21 • N74H21

SWITCHING CHARACTERISTICS, $V_{CC} = 5V$, $T_A = 25^\circ C$, $N = 10$

PARAMETER		TEST CONDITIONS	MIN	TYP ^{**}	MAX	UNIT
tpd0	Propagation delay time to logical 0 level	$C_L = 25pF$, $R_L = 280\Omega$		8.8	12	ns
tpd1	Propagation delay time to logical 1 level	$C_L = 25pF$, $R_L = 280\Omega$		7.6	12	ns

* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

** All typical values are at $V_{CC} = 5V$, $T_A = 25^\circ C$.

† Not more than one output should be shorted at a time and duration of short circuit test should not exceed 1 second.